

IEC SYSTEM FOR MUTUAL RECOGNITION OF TEST
CERTIFICATES FOR ELECTRICAL EQUIPMENT
(IECEE) CB SCHEME

SYSTEME CEI D'ACCEPTATION MUTUELLE DE
CERTIFICATS D'ESSAIS DES EQUIPEMENTS
ELECTRIQUES (IECEE) METHODE OC

CB TEST CERTIFICATE**CERTIFICAT D'ESSAI OC**

Product
Produit

Notebook PC

Name and address of the applicant
Nom et adresse du demandeur

ASUSTEK COMPUTER INC
4TH FL 150 LI-TE RD PEITOU TAIPEI 112 TAIWAN

Name and address of the manufacturer
Nom et adresse du fabricant

ASUSTEK COMPUTER INC
4TH FL 150 LI-TE RD PEITOU TAIPEI 112 TAIWAN

Name and address of the factory
Nom et adresse de l'usine

PROTEK (SHANGHAI) LTD
3768 XIU YAN RD KANG QIAO TOWN PUDONG NEW
DISTRICT, SHANGHAI
CHINA

Note: When more than one factory, please report on page 2
Note: Lorsque il y plus d'une usine, veuillez utiliser la 2^{ème} page

Additional Information on page 2
19Vdc, 1.75A (optional)

Ratings and principal characteristics
Valeurs nominales et caractéristiques principales

Trademark (if any)
Marque de fabrique (si elle existe)

ASUS



Type of Manufacturer's Testing Laboratories used
Type de programme du laboratoire d'essais
constructeur

Model / Type Ref.
Ref. De type

F205xxxxxxxxxxxxxxxxxxxx, R205xxxxxxxxxxxxxxxxxxxx,
X205xxxxxxxxxxxxxxxxxxxx
See Page 2

Additional information (if necessary may also be
reported on page 2)
Les informations complémentaires (si nécessaire,,
peuvent être indiqués sur la 2^{ème} page

Additionally evaluated to EN 60950-1:2006 /A11:2009 /A1:2010
/A12:2011 ; National Differences specified in the CB Test Report.
 Additional Information on page 2

A sample of the product was tested and found
to be in conformity with
Un échantillon de ce produit a été essayé et a été
considéré conforme à la

IEC 60950-1(ed.2), IEC 60950-1(ed.2);am1

As shown in the Test Report Ref. No. which forms
part of this Certificate
Comme indiqué dans le Rapport d'essais numéro de
référence qui constitue partie de ce Certificat

ASL14081808 issued on 2014-09-12

This CB Test Certificate is issued by the National Certification Body
Ce Certificat d'essai OC est établi par l'Organisme **National de Certification**



- UL (US), 333 Pfingsten Rd IL 60062, Northbrook, USA
- UL (Demko), Borupvang 5A DK-2750 Ballerup, DENMARK
- UL (JP), Marunouchi Trust Tower Main Building 6F, 1-8-3 Marunouchi, Chiyoda-ku, Tokyo 100-0005, JAPAN
- UL (CA), 7 Underwriters Road, Toronto, M1R 3B4 Ontario, CANADA

For full legal entity names see www.ul.com/ncbnames

Date: 2014-09-16

Signature:

Jan-Erik Storgaard



Ref. Certif. No.

DK-40914-UL

Model Details:

F205xxxxxxxxxxxxxxxxxxxxxx,R205xxxxxxxxxxxxxxxxxxxxxx,X205xxxxxxxxxxxxxxxxxxxxxx (x = A-Z, a-z, - or blank; y = 0-9, A-Z, a-z, - or blank, for marketing purpose and no impact safety related construction and critical components)

Factories:

PEGATRON CORP TAOYUAN MFG
5, SHING YEH ST, KWEI SHAN HSIANG, TAOYUAN 333
TAIWAN

TECH-COM (SHANGHAI) COMPUTER CO. LTD
68 SANZHUANG RD, SONGJIANG EXPORT PROCESSING ZONE, SHANGHAI 201613
CHINA

DIGITEK (CHONGQING) LTD
B01, SECTION C, AIRPORT FUNCTION ZONE, LIANGLU CUNTAN FREE TRADE PORT AREA, YUBEI DISTRICT
CHONGQING CITY
CHINA

TECH-FRONT (CHONGQING) COMPUTER CO LTD
18 ZONGBAO RD SHAPINGBA DISTRICT CHONGQING
CHINA

COMPAL INFORMATION TECHNOLOGY (KUNSHAN) CO LTD
58 1ST AVE A ZONE KUNSHAN COMPREHENSIVE FREE TRADE ZONE KUNSHAN JIANGSU
CHINA

COTEK ELECTRONICS (SUZHOU) CO LTD
288 MAYUN RD NEW DISTRICT SUZHOU JIANGSU 215011
CHINA

WISTRON INFOCOMM (KUNSHAN) CO LTD
FIRST AVE KUNSHAN INTEGRATED FREE TRADE ZONE KUNSHAN JIANGSU
CHINA

WISTRON INFOCOMM (CHONGQING) CO LTD
18-9 BAOHONG AVENUE WANGJIA SUBDISTRICT YUBEI DISTRICT CHONGQING 401120
CHINA

Additional information (if necessary)

Information complémentaire (si nécessaire)



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